

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/446,888	FUTAKATA ET AL.	
Examiner	Art Unit	
Pankaj Kumar	2611	

SEARCHED				
Class	Subclass	Date	Examiner	
375	130, 140, 141, 146, 147, 219	9/7/2007	PK	
375	220, 224	9/7/2007	PK	
375	377, 295	9/7/2007	PK	
375	316, 259	9/7/2007	PK	
455	450, 446	9/7/2007	PK	
455	447,456.6	9/7/2007	PK .	
455	456.1	9/7/2007	PK	
455	422.2	9/7/2007	PK	
455	403,3.01	9/7/2007	PK	
455	39,500	9/7/2007	PK	
455	73,91,95	9/7/2007	PK	
455	130	9/7/2007	PK	
370	464,431	9/7/2007	PK	
370	310	9/7/2007	PK	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
375	141	9/7/2007	PK	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST	9/7/2007	PK	
IEEE	9/7/2007	PK	
	<u>:</u>		